

<b>Notice of References Cited</b>	Application/Control No. 10/695,791	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Patrick J. Lee	Art Unit 2878	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-4,882,479	11-1989	Hino et al.	250/231.14
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	K	US-			
	L	US-			
	M	US-			

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	N					
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**NON-PATENT DOCUMENTS**

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